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Report No.: SZEM180400344902

Page: 1 of 8

SAR Evaluation Report

Application No.: SZEM1804003449CR
Applicant: Sariana LLC
Address of Applicant: 7365 Mission Gorge Road Suite G San Diego, CA 92120 U.S.A.
Manufacturer: ORtek Technology, INC.
Address of Manufacturer: 13F, Number 150, Jian-Yi Rd, Zhonghe Dist, New Taipei City, Taiwan.
Factory: ORtek Technology, INC.
Address of Factory: 13F, Number 150, Jian-Yi Rd, Zhonghe Dist, New Taipei City, Taiwan.
Equipment Under Test (EUT):
EUT Name: Satechi Slim Wireless Keyboard
Model No.: ST-TCAWK, ST-TCAWKS, ST-TCAWKM, ST-TCAWG, ST-TCAWR ♣
 ♣ Please refer to section 4.1 of this report which indicates which model was actually tested and which were electrically identical.
Trade mark: SATECHI
FCC ID: ZE9-TCAWK
Standards: 47 CFR Part 1.1307
 47 CFR Part 2.1093
 KDB447498D01 General RF Exposure Guidance v06
Date of Receipt: 2018-05-02
Date of Test: 2018-05-03 to 2018-05-10
Date of Issue: 2018-05-14

Test Result :	PASS*
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* In the configuration tested, the EUT complied with the standards specified above.



Keny Xu
 EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2018-05-14		Original

Authorized for issue by:				
				
		<hr/>		
		Moon Zhang /Project Engineer		
				
		<hr/>		
		Eric Fu /Reviewer		



3 Contents

	Page
1 COVER PAGE	1
2 VERSION	2
3 CONTENTS	3
4 GENERAL INFORMATION	4
4.1 GENERAL DESCRIPTION OF EUT	4
4.2 TEST LOCATION	6
4.3 TEST FACILITY	6
4.4 DEVIATION FROM STANDARDS	7
4.5 ABNORMALITIES FROM STANDARD CONDITIONS	7
4.6 OTHER INFORMATION REQUESTED BY THE CUSTOMER	7
5 SAR EVALUATION.....	8
5.1 RF EXPOSURE COMPLIANCE REQUIREMENT	8
5.1.1 <i>Standard Requirement</i>	8
5.1.2 <i>Limits</i>	8
5.1.3 <i>EUT RF Exposure</i>	8



4 General Information

4.1 General Description of EUT

Power supply:	POWER SUPPLY BY DC 5V ADAPTOR Li-ion battery: 3.7V 180mAh 0.666Wh
Cable:	Type-C cable:100cm unshielded
Antenna Gain	-0.58dBi
Antenna Type	PIFA Antenna
BT Version:	V3.0
Channel Spacing	1MHz
Modulation Type	GFSK
Number of Channels	79
Operation Frequency	2402MHz to 2480MHz
Spectrum Spread Technology	Frequency Hopping Spread Spectrum(FHSS)

Channel list							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
2	2404MHz	22	2424MHz	42	2444MHz	62	2464MHz
3	2405MHz	23	2425MHz	43	2445MHz	63	2465MHz
4	2406MHz	24	2426MHz	44	2446MHz	64	2466MHz
5	2407MHz	25	2427MHz	45	2447MHz	65	2467MHz
6	2408MHz	26	2428MHz	46	2448MHz	66	2468MHz
7	2409MHz	27	2429MHz	47	2449MHz	67	2469MHz
8	2410MHz	28	2430MHz	48	2450MHz	68	2470MHz
9	2411MHz	29	2431MHz	49	2451MHz	69	2471MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
12	2414MHz	32	2434MHz	52	2454MHz	72	2474MHz
13	2415MHz	33	2435MHz	53	2455MHz	73	2475MHz
14	2416MHz	34	2436MHz	54	2456MHz	74	2476MHz
15	2417MHz	35	2437MHz	55	2457MHz	75	2477MHz
16	2418MHz	36	2438MHz	56	2458MHz	76	2478MHz
17	2419MHz	37	2439MHz	57	2459MHz	77	2479MHz
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		



Selected Test Channel	
Channel	Frequency
The lowest channel (CH0)	2402MHz
The middle channel (CH39)	2441MHz
The highest channel (CH78)	2480MHz

Remark:

Model No.: ST-TCAWK, ST- TCAWKS, ST-TCAWKM, ST-TCAWG, ST-TCAWR

Only the model ST-TCAWK was tested, since the electrical circuit design, layout, components used, internal wiring and functions were identical for all the above models, only different on colour.



4.2 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

4.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

• Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.



4.4 Deviation from Standards

None.

4.5 Abnormalities from Standard Conditions

None.

4.6 Other Information Requested by the Customer

None.



5 SAR Evaluation

5.1 RF Exposure Compliance Requirement

5.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

5.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$\frac{[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot \sqrt{f(\text{GHz})}}{\leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where}}$$

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation¹⁷

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

5.1.3 EUT RF Exposure

The Max. power (including tune-up tolerance) is	-0.08 dBm on the lowest channel	2.402	GHz (*)
-0.08 dBm logarithmic terms convert to numeric result is nearly 0.98 mW			
According to the formula, calculate the test exclusion thresholds:			
$\text{General RF Exposure} = \frac{(\text{Max. Power of channel, including tune-up tolerance, mW}) \cdot \sqrt{f(\text{GHz})}}{(\text{min. test separation distance, mm})}$			
$\text{General RF Exposure} = (0.98 \text{ mW} / 5 \text{ mm}) \times \sqrt{2.402 \text{ GHz}} = 0.30$		(1)	
SAR requirement:			
S = 3.0		(2)	
(1) < (2)			
So the SAR report is not required.			
(*) Max. power refer to Report No.:SZEM180400344901			

- End of the Report -